

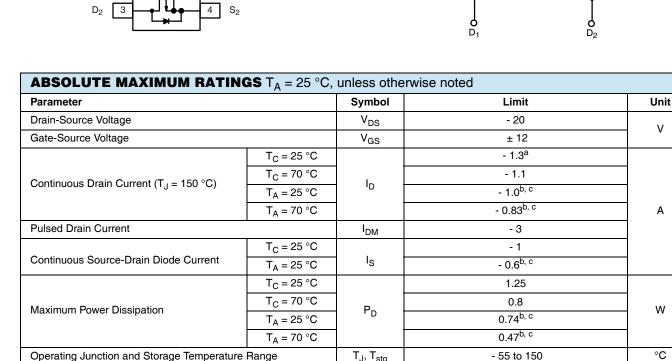
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	$R_{DS(on)}$ (Ω) $I_{D}$ (A)				
	0.183 at V <sub>GS</sub> = - 4.5 V	- 1.3 <sup>a</sup>				
- 20	0.262 at V <sub>GS</sub> = - 2.5 V	- 1.2	1.6 nC			
	0.383 at V <sub>GS</sub> = - 1.8 V	- 1.0				

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- PWM Optimized
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

Load Switch for Portable Devices



THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	$t \le 5 s$	R <sub>thJA</sub>	130	170 <sub>°</sub> ر			
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	80	100	°C/W		

T<sub>J</sub>, T<sub>stg</sub>

Notes:

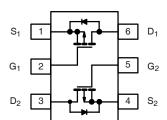
a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

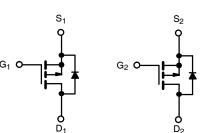
c. t = 5 s.

d. Maximum under steady state conditions is 220 °C/W.

Operating Junction and Storage Temperature Range



SOT-323-6





FREE Availabl



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA				V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 20		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μΑ		2		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	- 0.3		- 1.3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 8 V$			± 100	nA
		$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	μA
Zero Gate Voltage Drain Current	IDSS	$V_{DS}$ = - 20 V, $V_{GS}$ = 0 V, $T_{J}$ = 85 °C			- 10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le$ - 5 V, $V_{GS}$ = - 4.5 V	- 3			Α
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 0.91 A		0.183	0.201	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -2.5 \text{ V}, \text{ I}_{\text{D}} = -0.8 \text{ A}$		0.262	0.288	
		V <sub>GS</sub> =- 1.8 V, I <sub>D</sub> =- 0.25 A		0.383	0.421	
Forward Transconductance <sup>a</sup> g <sub>fs</sub>		V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 0.91 A		2		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			237		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = - 10 V, $V_{GS}$ = 0 V, f = 1 MHz		26		
Reverse Transfer Capacitance	C <sub>rss</sub>			16		
Total Gate Charge	Q <sub>g</sub> Q <sub>gs</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_{D} = -1.1 \text{ A}$		2.6	4.0	nC
Iotal Gale Charge				1.6	2.4	
Gate-Source Charge		$V_{DS}$ = - 10 V, $V_{GS}$ = - 4.5 V, $I_{D}$ = - 1.1 A		0.36		
Gate-Drain Charge	Q <sub>gd</sub>			0.33		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		7.5		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			12	20	0 5 5 0 0
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, \text{ R}_{L} = 12 \Omega$		27	40	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 0.83 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		15	25	
Fall Time	t <sub>f</sub>			10	15	
Turn-On Delay Time	t <sub>d(on)</sub>			2	5	
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, \text{ R}_{\text{I}} = 12 \Omega$		12	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 0.83 A, $V_{GEN}$ = - 8 V, $R_g$ = 1 $\Omega$		12	20	
Fall Time	t <sub>f</sub>			10	15	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 1.0	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 3.0	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 0.9 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns
Body Diode Reverse Recovery Charge Q <sub>rr</sub>				15	30	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -0.83 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		12		
Reverse Recovery Rise Time	t <sub>b</sub>			13		ns

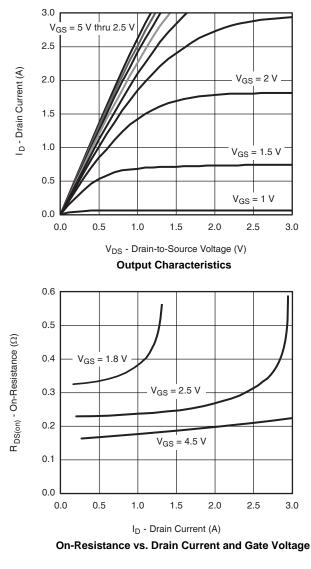
Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %

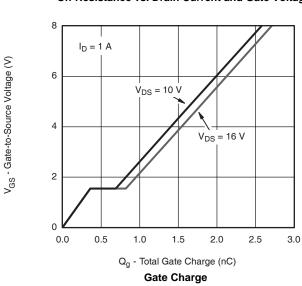
b. Guaranteed by design, not subject to production testing.

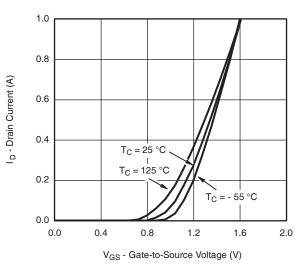
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



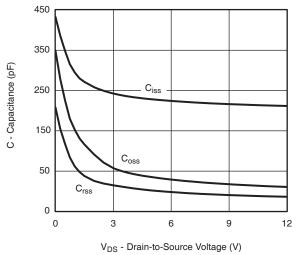


#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

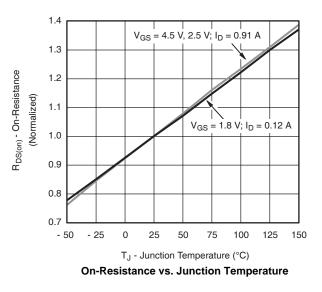




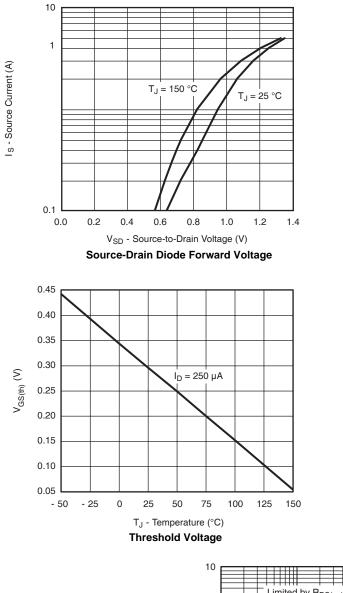
**Transfer Characteristics** 



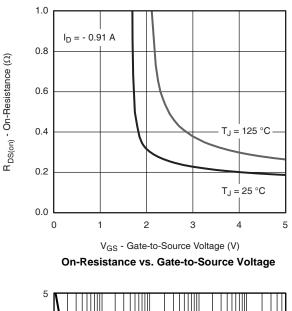
Capacitance

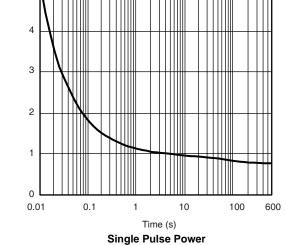


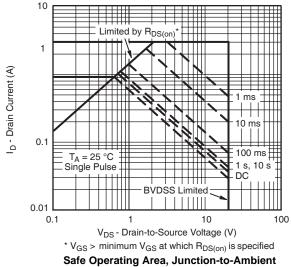




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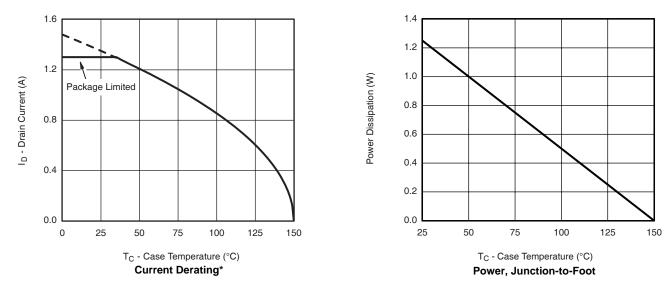




Power (W)



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

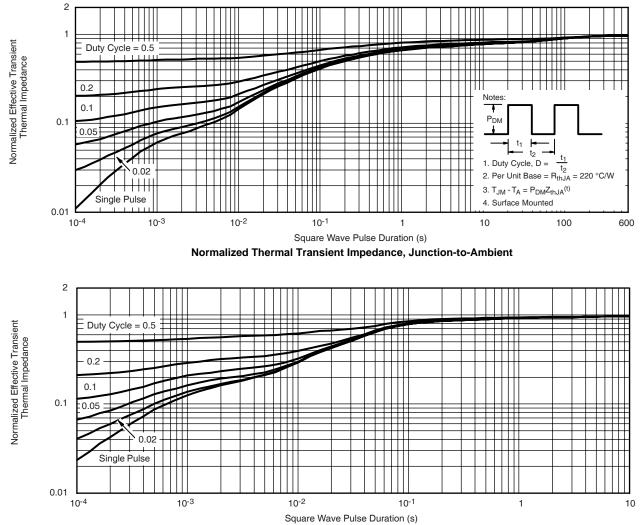


\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## DTS2211 www.din-tek.jp

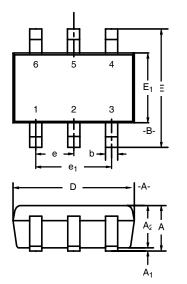
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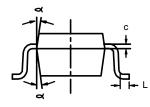


Normalized Thermal Transient Impedance, Junction-to-Foot



# Package Information www.din-tek.jp

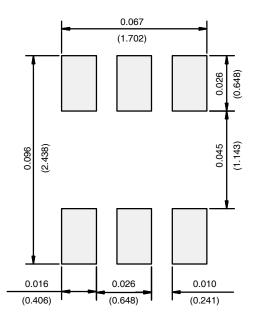




	MILLIMETERS			INCHES		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.90	-	1.10	0.035	-	0.043
A <sub>1</sub>	-	-	0.10	-	-	0.004
A <sub>2</sub>	0.80	-	1.00	0.031	-	0.039
b	0.15	-	0.30	0.006	-	0.012
С	0.10	-	0.25	0.004	-	0.010
D	1.80	2.00	2.20	0.071	0.079	0.087
Е	1.80	2.10	2.40	0.071	0.083	0.094
E <sub>1</sub>	1.15	1.25	1.35	0.045	0.049	0.053
е	0.65BSC			0.026BSC		
e <sub>1</sub>	1.20	1.30	1.40	0.047	0.051	0.055
L	0.10	0.20	0.30	0.004	0.008	0.012
a	7°Nom			7°Nom		



### **RECOMMENDED MINIMUM PADS FOR SOT323: 6-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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